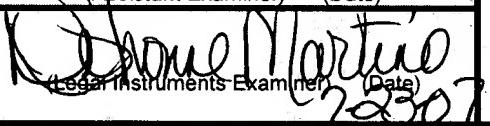


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/936,565	SAUK
	Examiner	Art Unit
	Christopher H. Yaen	1643

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
530	300	514	2
INTERNATIONAL CLASSIFICATION			
C	0	7	K 5/00
A	6	1	K 38/00
			/
			/
			/

(Assistant Examiner) _____	(Date) _____	 /Christopher Yaen/ C.Y. Primary Examiner 7/18/07		Total Claims Allowed: 15
 Diane Martinez Test Instruments Examiner	(Date) 2007	(Primary Examiner)	(Date)	O.G. Print Claim(s) 34
				O.G. Print Fig. None

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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